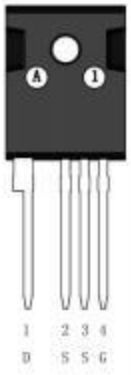
JX4S0060R065M

650V N-Channel MOSFET

Description

Silicon Carbide (SiC) MOSFET use a completely new technology that provide superior switching performance and higher reliability compared to Silicon. In addition, the low ON resistance and compact chip size ensure low capacitance and gate charge. Consequently, system benefits include highest efficiency, faster operating frequency, increased power density, reduced EMI, and reduced system size.

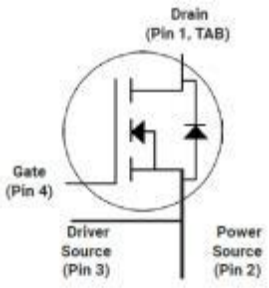


Features

- High Speed Switching with Low Capacitances
- High Blocking Voltage with Low RDS(on)
- Optimized package with separate driver source pin
- Easy to parallel and simple to drive
- ROHS Compliant, Halogen free

Application

- EV Charging
- DC/DC Converters
- Switch Mode Power Supplies
- Power Factor Correction Modules
- Solar PV inverters



Ordering Information

Part Number	Marking	Package	Packaging
JX4S0060R065M	JX4S0060R065M	TO-247	Tube

Absolute Maximum Ratings(Tc=25°C)

Symbol	Parameter	Value	Unit
V_{DS}	Drain-Source Voltage	650	V
I_D	Drain Current(continuous)at Tc=25°C	36	A
I_D	Drain Current(continuous)at Tc=100°C	26	A
I_{DM}	Drain Current (pulsed)	100	A
V_{GS}	Gate-Source Voltage	-10/+22	V
P_D	Power Dissipation T_C = 25°C	150	W
T_J, Tstg	Junction and Storage Temperature Range	-55 to +150	°C

Electrical Characteristics(T_J = 25°C unless otherwise specified)

Typical Performance-Static

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
BV_{DS}	Drain-source Breakdown Voltage	I_D=250uA,V_{GS}=0V	650			V
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS} =650V, V_{GS} =0V, T_J=25°C			100	μA
I_{GSS}	Gate-body Leakage Current	V_{DS} =0 V ; V_{GS} =-10 to 20V		10	250	nA
$V_{GS(th)}$	Gate Threshold Voltage	V_{DS}= V_{GS}, I_D=5mA	2	3	4	V
V_{GSon}	Recommended turn-on Voltage	Static		20		V
V_{GSoff}	Recommended turn-off Voltage			-5		V
$R_{DS(on)}$	Static Drain-source On Resistance	V_{GS}=20V, I_D=15A		60	80	mΩ
		V_{GS}=20V,I_D=15A T_J=150°C		75		mΩ

Typical Performance-Dynamic

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
C_{iss}	Input Capacitance	V_{DS}=600V,f=1MHz , V_{AC}=25mV		1138		pF
C_{oss}	Output Capacitance			88.8		pF
C_{rss}	Reverse Transfer Capacitance			9.6		pF
g_{fs}	Transconductance	V_{DS}=20V , I_D=15A		11		S
E_{OSS}	C_{OSS} Stored Energy	V_{DS}=600V,f=1MHz		17		μJ
E_{ON}	Turn-On Energy （Body Diode）	V_{DS}=400V,V_{GS}=-5/20V，I_D=15A， L=150uH T_J=150°C		75		μJ
E_{OFF}	Turn-Off Energy （Body Diode）			8.6		μJ
Q_g	Total Gate Charge	V_{DS}=400V, V_{GS}=-5V/20V, I_D = 15 A		64		nC
Q_{gs}	Gate-source Charge			13.5		nC
Q_{gd}	Gate-Drain Charge			18.3		nC
$R_{G\ (int)}$	Internal Gate Resistance	f=1MHz,V_{AC}=25mV		3		Ω
$t_{d(on)}$	Turn-on Delay Time	V_{DS}=400V,V_{GS}=-5V/20V, I_D =15A, L=150 μH Rext=2.5Ω		10		ns
t_r	Rise Time			13.8		ns
$t_{d(off)}$	Turn-off Delay Time			20		ns
t_f	Fall Time			8.8		ns

Typical Performance-Reverse Diode(T_J = 25℃ unless otherwise specified)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
V_{FSD}	Forward Voltage	V_{GS}=0V,I_F=7.5A,T_J=25°C		5.2	6	V
		V_{GS}=0V,I_F=7.5A,T_J=150°C		4.8	6	V
Is	Continuous Diode Forward Current	V_{GS}=0V， T_C=25°C		22		A
t_{rr}	Reverse Recovery Time	V_{GS}=-5 V, I_F=15 A, V_R=400 V, T_J=150°C di/dt= 2400 A/μs		19		nS
Q_{rr}	Reverse Recovery Charge			120		nC
I_{rrm}	Peak Reverse Recovery Current			15		A

Thermal Characteristics

Symbol	Parameter	Value.	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	0.83	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	40	°C/W

The values are based on the junction-to case thermal impedance which is measured with the device mounted to a large heat sink assuming maximum junction temperature of Tj(max)=150°C

Electrical Characteristics

Fig1. Output characteristics (T_J = 25 °C)

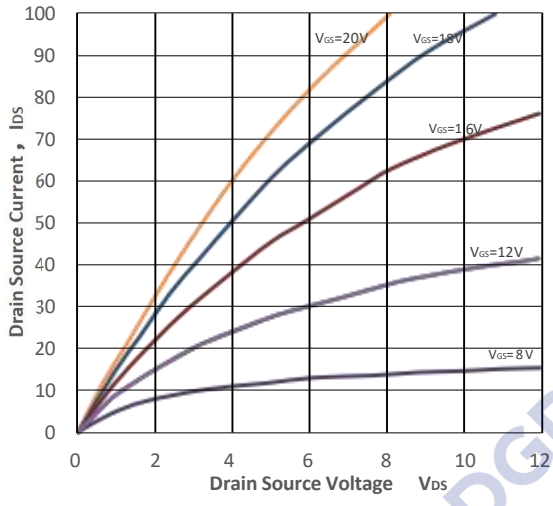


Fig2. Output characteristics (T_J = 150 °C)

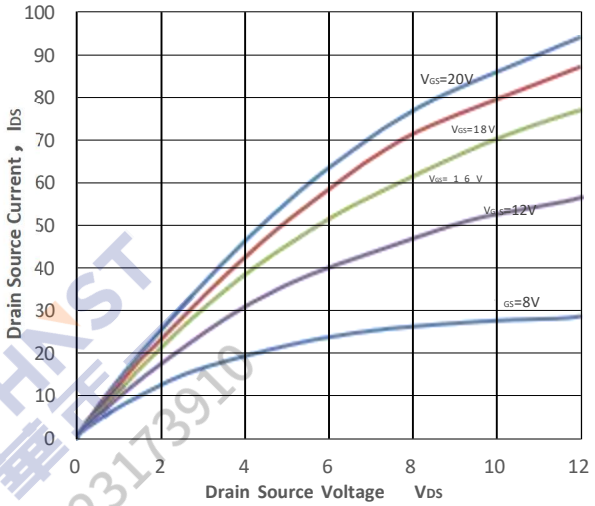


Fig3.Normalized On-Resistance vs. Temperature

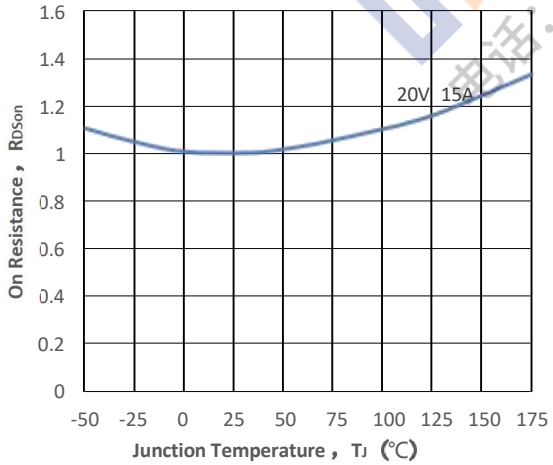


Fig4. On-Resistance vs. Temperature

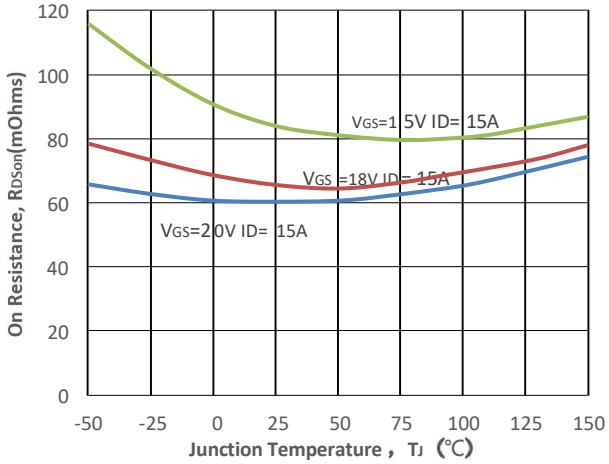


Fig5. Transfer Characteristic

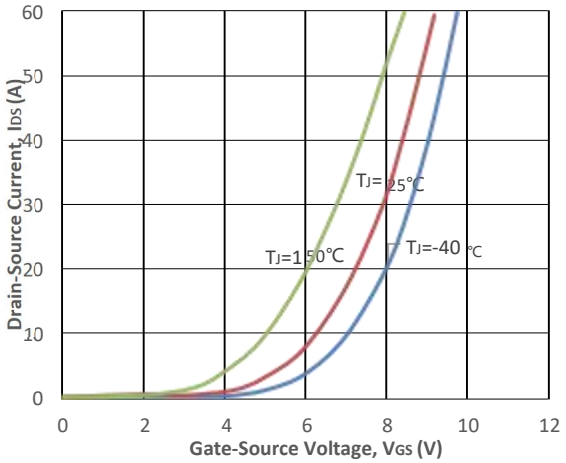


Fig6. Body Diode Characteristic at 25°C

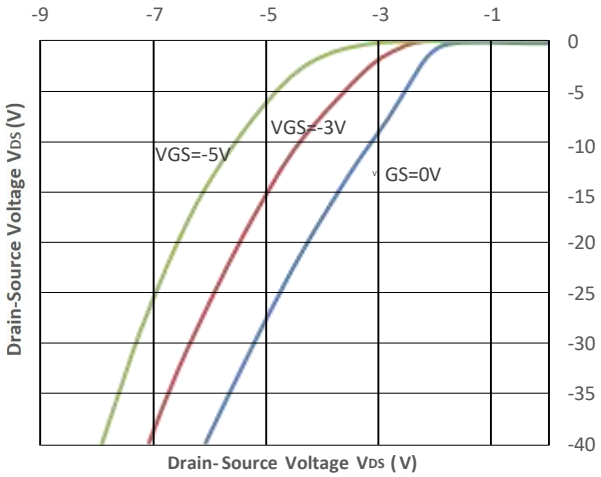


Fig7.Threshold Voltage vs. Temperature

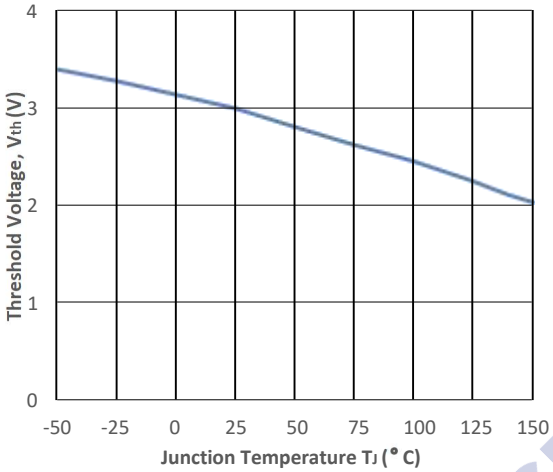


Fig8. Gate Charge Characteristics

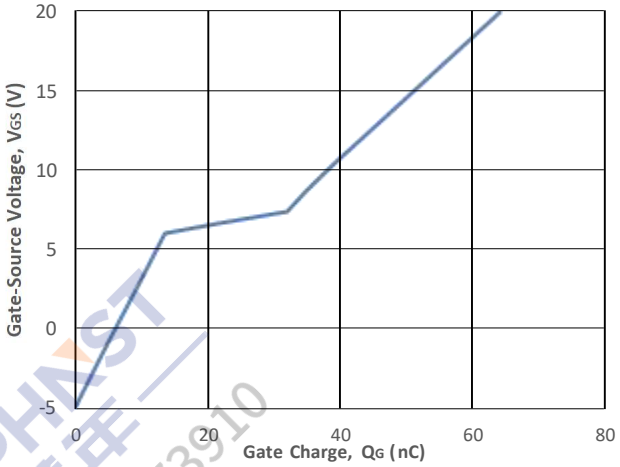


Fig9. 3rd Quadrant Characteristic at 25°C

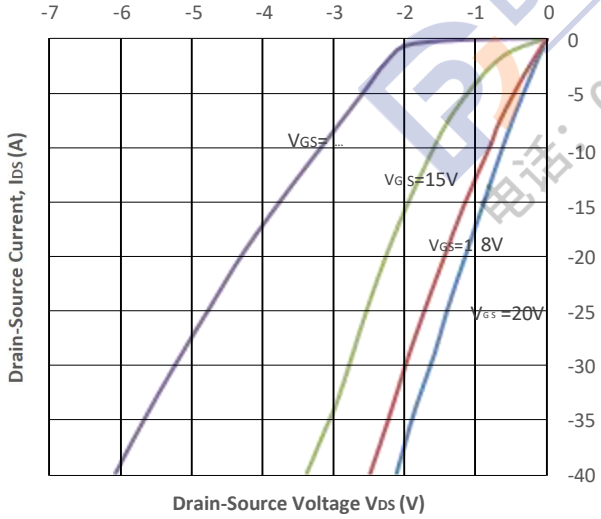


Fig10. Output Capacitor Stored Energy

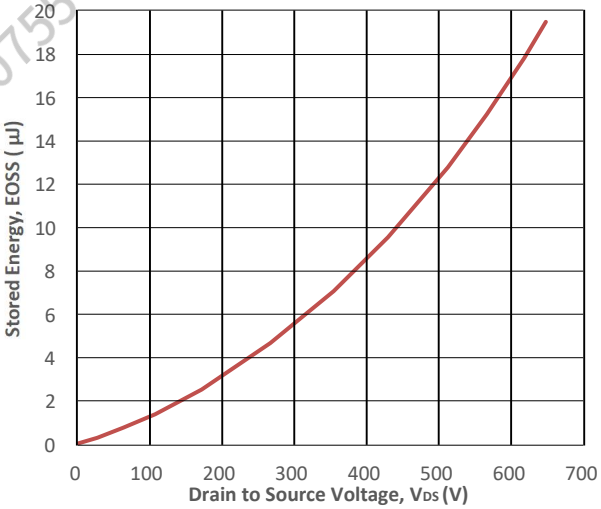


Fig11. Capacitances vs. Drain-Source

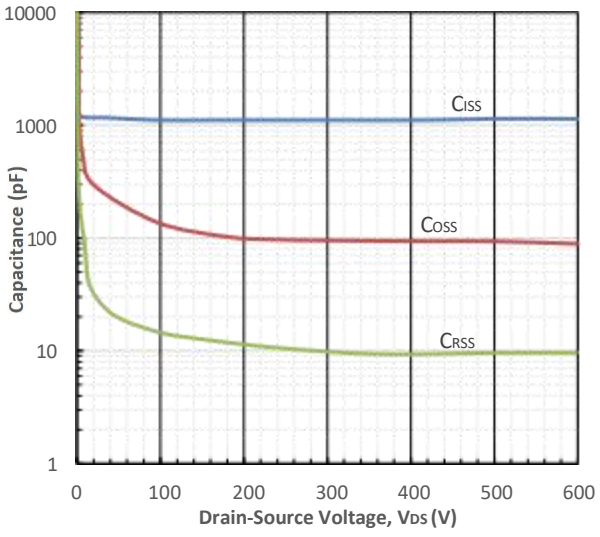


Fig12. Max Power Dissipation Derating Vs TC

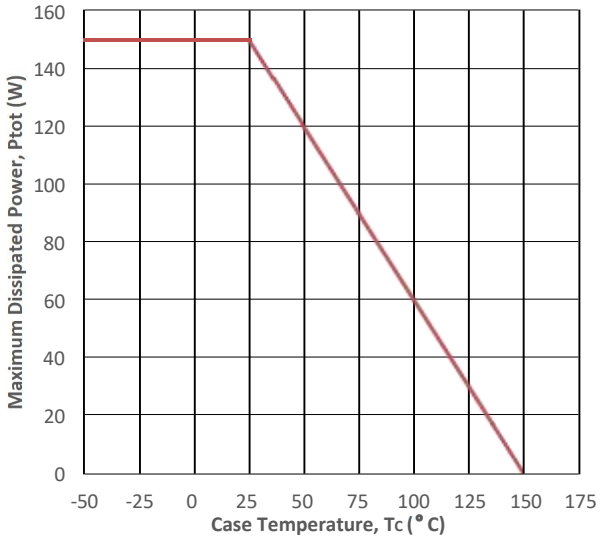


Fig13. Switching Energy vs. Drain Current

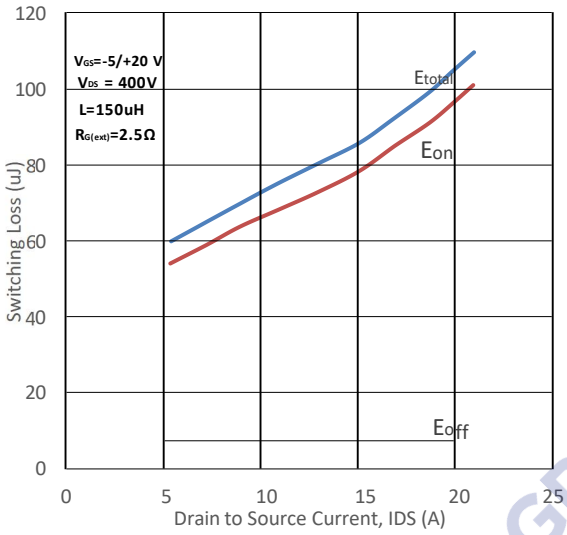


Fig14. Switching Energy vs. RG(ext)

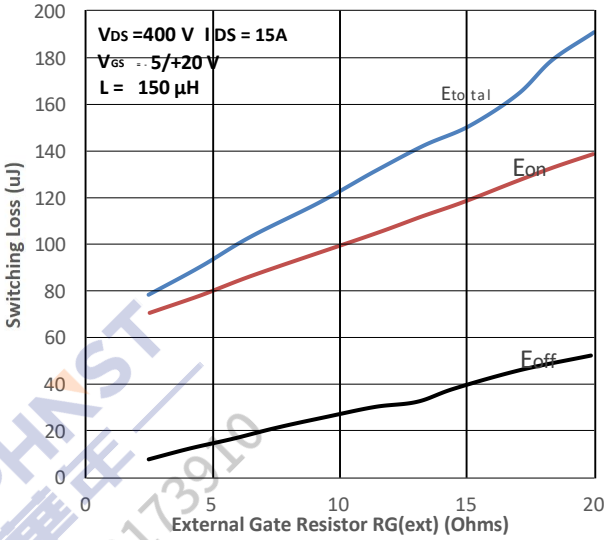


Fig15. Switching Energy vs. Temperature

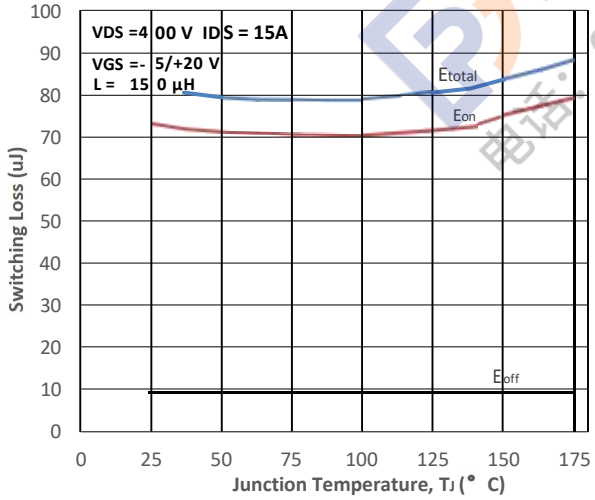


Fig16. Switching Times vs. RG(ext)

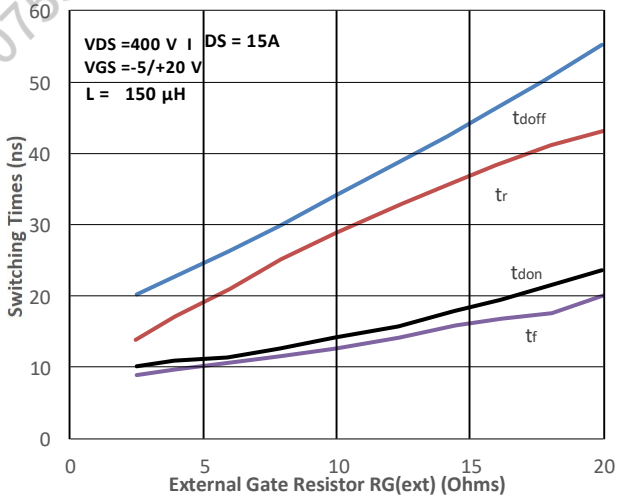


Fig17.Transient Thermal Impedance

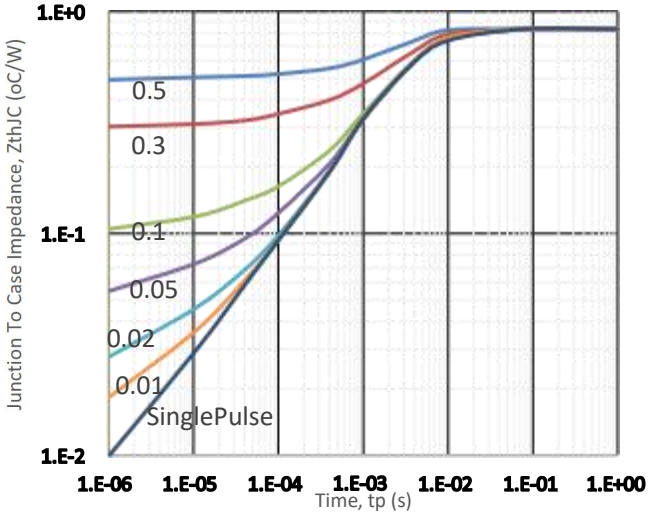
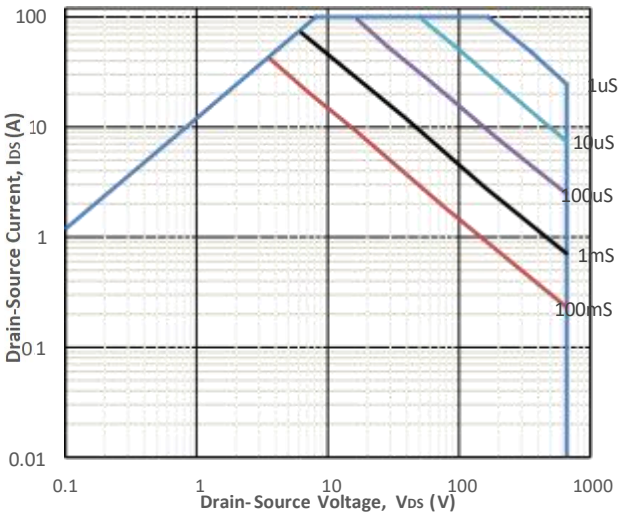
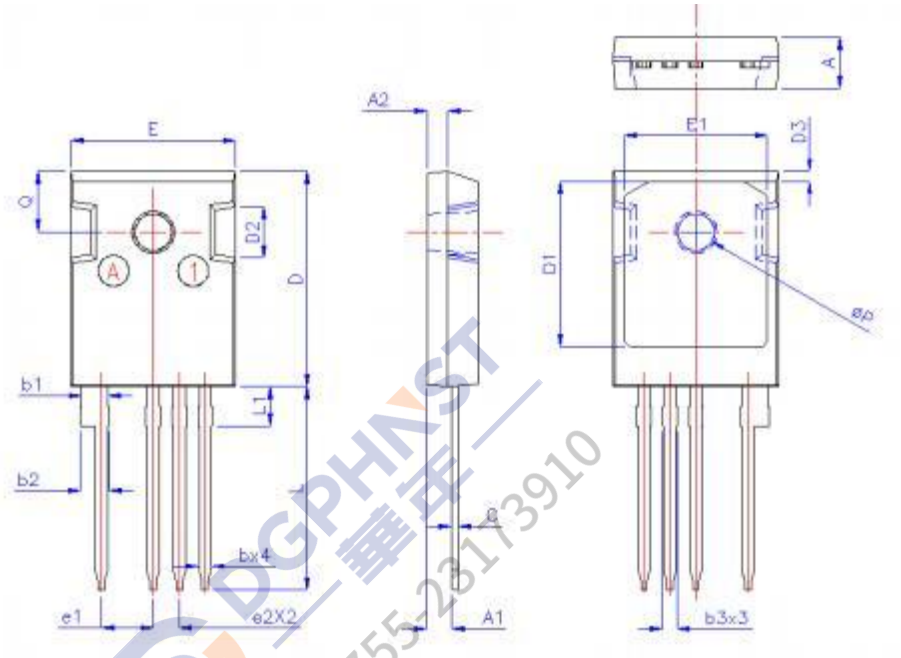


Fig18. Safe Operating Area



Package Drawing:



Dimensions （ UNIT：mm）

SYMBDLS	DIMENSIONS IN MILLIMETERS			DIMENSIONS IN INCHES		
	MIN	NOM	MAX	MIN	NOM	MAX
A	4.9	5	5.1	0.193	0.197	0.201
A1	2.31	2.42	2.52	0.091	0.095	0.099
A2	1.9	2	2.1	0.075	0.079	0.083
b	1.16	1.22	1.27	0.046	0.048	0.050
b1	1.15	1.2	1.25	0.045	0.047	0.049
b2	2.61	2.76	2.91	0.103	0.109	0.115
b3	1.36	1.42	1.47	0.054	0.056	0.058
C	0.59	0.62	0.66	0.023	0.024	0.026
D	20.9	21	21.1	0.823	0.827	0.831
D1	15.94	16.24	16.54	0.628	0.639	0.651
D2		5		0.197 TYP		
D3	0.8	0.95	1.1	0.031	0.037	0.043
e	5.08 BSC				0.200 BSC	
e1	2.54 BSC				0. 100BSC	
E	16.05	16.15	16.25	0.632	0.636	0.640
E1	13.82	14.02	14.26	0.544	0.552	0.561
L	19.75	19.95	20.15	0.778	0.785	0.793
L1	——	——	3.87	——	——	0.152
Q	5.95 BSC			0.234BSC		
ØP	3.45	3.6	3.75	0.136	0.142	0.148